The Classification for Early Onset Scoliosis (C-EOS) Identifies Patients at Higher Risk for Complications at 5 Years of Follow Up

Howard Y Park BA; Hiroko Matsumoto MA; Tricia St. Hilaire BS; Jeff B Pawelek BS; John M Flynn; David L Skaggs; Behrooz Akbarnia, MD, David P Roye MD, Michael G Vitale MD MPH

Ana Lucia Professor of Orthopaedic Surgery
Columbia University Medical Center
Co Director, Division of Pediatric Orthopaedic Surgery
Chief, Pediatric Spine and Scoliosis Service
Medical Director, MSCH Initiative to Make Care Better
Children's Hospital of New York





-Disclosures-

Michael G. Vitale, MD MPH

Disclosure: I DO have a financial relationship with a commercial interest.

Royalties: Biomet

Consultant: Stryker, CWSDSG, Biomet

Research Support: CWSDRF, SRS, POSNA

Travel Support: CWSDSG, FoxPSDSG

Other: CWSDSG - BOD

POSNA - BOD

Study in part Funded by a Grant from the CWSDSG (aka CSF)



Improving the Evidence Base in EOS

Development of a Research Infrastructure Via five parallel efforts

Endpoints

Development/Validation of a Disease-Specific QoL Measure

Equipoise

Identifying Clinical Equipoise in the Field of EOS

Classification-EOS

Development / Validation of Classification for EOS

Standardizing Complications

Standardize Way We Define and Report Complications

Clinical Trials

Proximal Anchors: Rib Vs Spine – Retrospective (Prospective Underway)

Background

Development of C-EOS

Age

Continuous Prefix **Etiology**

Congenital/ Structural

Neuro Muscular

Syndromic

<u>I</u>diopathic

Cobb Angle (Major Curve)

1: <20°

2: 20-50°

3: 51-90°

4: >90°

Maximum Total Kyphosis

(-) <20°

N: 20-50°

(+):>50°

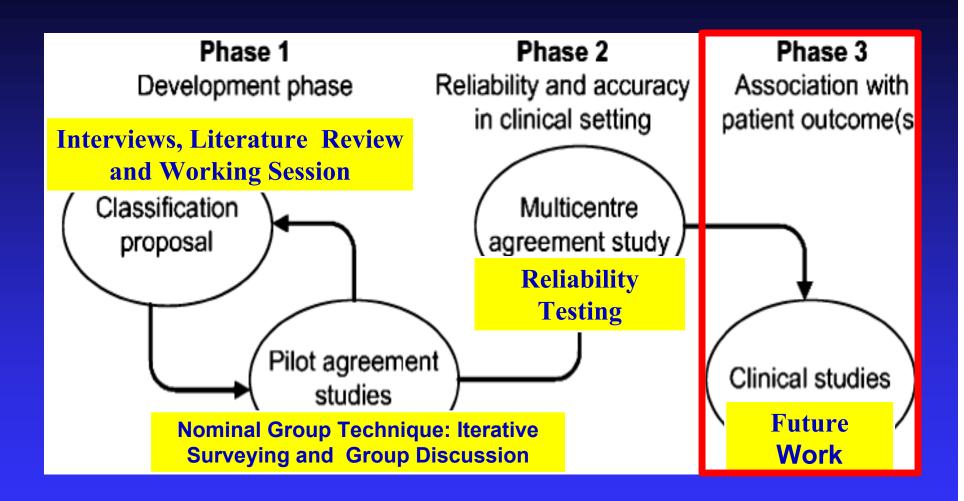
Progression Modifier (optional)

P0: <10°/yr

P1:10-19°/ yr

P2: >20°/yr

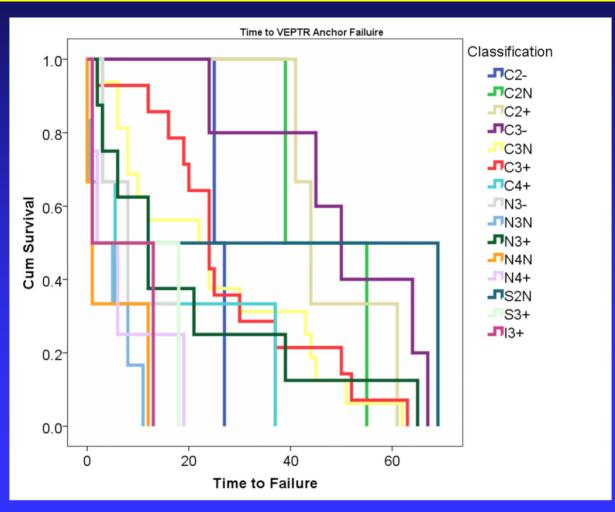
Methods: Validation Pathway



Audige L et al. (2005). A concept for the validation of fracture classifications. J Orthop Trauma. 19:404-409

Initial Validation of C-EOS

The Classification for Early-Onset Scoliosis (C-EOS) Predicts Timing of VEPTR Anchor Failure



Purpose: Further Validation of the C-EOS

To validate the prognostic potential of the C-EOS by examining the rate and severity of complications in surgical EOS patients

Age
Continuous
Prefix

Congenital/Structural

NeuroMuscular

Syndromic

Idiopathic

Cobb Angle
(Major Curve)

1: <20°

2: 20-50°

3: 51-90°

4: >90°

Maximum
Total Kyphosis

(-) <20°

N: 20-50°

(+): >50°

Progression
Modifier
(optional)

P0: <10°/yr

P1:10-19°/
yr

P2: >20°/yr

Methods

•Methods:





- Retrospective review of CSF & GSSG databases
- Inclusion: EOS pts with *min 5 year follow-up* from index surgery

•Outcomes:

- Complications
 - Rate
 - Severity



Classification of Complications in Growing Spine Surgery JT Smith, D Skaggs, C Johnston, MG Vitale

Device Related Severity Grade

1 – No unplanned surgery eg HWR prominence

2A – 1 unplanned trip to OR eg rod fracture

2B – Multiple trips to OR eg infection

3 – Alteration in treatment plan eg fusion

52 of 78 Patients Experiences Some Complication at 5 years

Complication Grade:

1 (resolved):	18
2a (1 unplanned trip to OR):	24
2b (multiple):	4
3 (change in outcome)	18

Etiology Alone Did not Predict Rate of Device Related Complications, N=161

Rate of Device Related Complications of any Severity per Etiology

Etiology		Percent
Congenital	28/50	56.0%
Idiopathic	19/32	59.4%
Neuromuscular	30/45	66.7%
Syndromic	23/34	67.6%
		P = .629

Rate of Device Related Complications ≥ 2A per Etiology

Etiology		Percent
Idiopathic	7/32	21.9%
Congenital	18/50	36%
Neuromuscular	19/45	42.2%
Syndromic	15/34	44.1
		P = .218

No Idiopathic Patient Experienced a Complication Which Required Return to OR or Change in Treatment

Irrespective of Cobb Angle, Kyphosis:
•100% Idiopathic case complications ≤ 2A

Cobb Angle Alone Did Not Predict Rate of Complications

Rate of Device Related Complications of any Severity per Cobb Angle

Cobb Angle		Percent
≤20° (1)	2/2	100.0%
21-50° (2)	14/21	66.7%
51-90° (3)	70/112	62.5%
>90° (4)	13/24	54.2%
		P = .561

Rate of Device Related Complications ≥ 2A per Cobb Angle

Cobb Angle		Percent
≤20° (1)	0/2	0.0%
21-50° (2)	9/21	42.9%
51-90° (3)	43/112	38.4%
>90° (4)	7/24	29.2%
		P = .531

Kyphosis Alone did not predict Rate of Complications

Rate of Device Related Complications of any Severity per Grade Kyphosis

Kyphosis		Percent
≤ 20° (-)	4/5	80.0%
21-50° (N)	33/47	70.2%
>51° (+)	21/31	67.7%
		P = .855

Rate of Device Related Complications ≥ 2A per Grade Kyphosis

Kyphosis		Percent
≤ 20° (-)	3/5	60.0%
21-50° (N)	23/47	48.9%
>51° (+)	11/31	35.5%
		P = .391

Rate of Device Related Complications by C-EOS, N=78

Numbers across cells too small for comparison

Rate of Device Related Complication of any Severity per C-EOS

C-EOS		Percent
N4+	0/0	0.0%
N2N	1/2	50.0%
I2N	2/4	50.0%
I3N	3/5	60.0%
C3N	10/16	62.5%
S3 +	2/3	66.7%
C3-	2/3	66.7%
I3+	2/3	66.7%
C3+	5/7	71.4%
C2N	3/4	75.0%
S2N	3/4	75.0%
N3+	4/5	80.0%
S3N	4/5	80.0%
S4 +	1/1	100%
S3-	1/1	100%
C4+	1/1	100%
N3N	5/5	100%
C3+	2/2	100%
N2+	1/1	100%
N1+	1/1	100%
I4+	3/3	100%

Severe Complications (10) Occur in Patients with Large Cobb and in Hyperkyphotic Patients

C-EOS	C-EOS Complication Severity				
	1	2A	2B	3	Total
C2N	2	0	1	0	3
С3-	1	1	0	0	1
C3N	2	8	0	0	10
C3+	1	2	0	2	5
C4+	0	0	0	1	1
N1+	1	0	0	0	1
N2N	0	1	1	0	2
N2+	0	0	1	0	1
N3N	1	4	0	0	5
N3+	2	0	1	1	4
N4+	0	0	0	0	1
S2N	1	1	0	1	3
S3-	0	1	0	0	2
S3+	2	0	0	0	2
S3N	1	2	0	1	4
S4+	0	0	0	1	1
I2N	1	1	0	0	2
I3N	1	2	0	0	3
I3+	2	0	0	0	2
I4+	0	1	0	0	1

Among the most severe complications (Class 3): 6/6 Cobb > 51° 4/6 Hyperkyphotic 0/6 Idiopathic

Conclusions

- 67% of patients experience some complication within first 5 years, although only 18% affect outcome
- Non-idiopathic patients experience more, and more significant complications
- Severe complications occur in patients with large Cobb, hyperkyphosis and non-idiopathic etiology
- C-EOS can predict frequency and severity of complications

Thank You

